

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination DEKONING ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0004883 a1	01-2002	NGUYEN et al.	711/111
	B	US-5,151,990	09-1992	Allen et al.	711/170
	C	US-5,796,633	08-1998	Burgess et al.	702/187
	D	US-6,408,359 B1	06-2002	Ito et al.	711/114
	E	US-6,314,503 B1	11-2001	D'Errico et al.	711/165
	F	US-6,571,314 B1	05-2003	Komachiya et al.	711/114
	G	US-6,529,996 B1	03-2003	Nguyen et al.	711/114
	H	US-6,145,066 A	11-2000	Atkin, Carey Phillip	711/114
	I	US-5,905,995 A	05-1999	Tabuchi et al.	711/114
	J	US-6,487,562 B1	11-2002	Mason et al.	707/205
	K	US-5,897,661 A	04-1999	Baranovsky et al.	711/170
	L	US-6,446,161 B1	09-2002	Yamamoto et al.	711/114
	M	US-6,233,607 B1	05-2001	Taylor et al.	709/217

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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